

# UNISONIC TECHNOLOGIES CO., LTD

UT50P10H **POWER MOSFET Preliminary** 

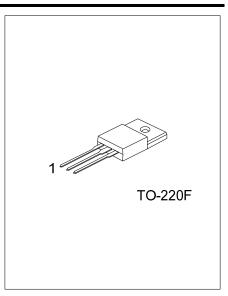
# -50A, -100V P-CHANNEL **POWER MOSFET**

#### DESCRIPTION

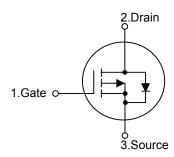
The UT50P10H uses advanced proprietary, planar stripe, DMOS technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with low gate voltages. This device is suitable to be used in low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

#### **FEATURES**

- \*  $R_{DS(ON)} \le 65 \text{ m}\Omega$  @  $V_{GS}$ =-10V,  $I_{D}$ =-25A
- \* High Switching Speed
- \* High Cell Density Trench Technology



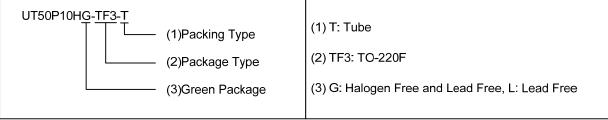
#### **SYMBOL**



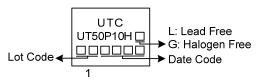
#### **ORDERING INFORMATION**

Ordering Number		Doolsono	Pin Assignment			Doolsing
Lead Free	Halogen Free	Package	1	2	3	Packing
UT50P10HL-TF3-T	UT50P10HG-TF3-T	TO-220F	G	D	S	Tube

Note: Pin Assignment: G: Gate D: Drain S: Source



# **MARKING**



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# ■ **ABSOLUTE MAXIMUM RATINGS** (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	V <sub>DSS</sub>	-100	V
Gate-Source Voltage	V <sub>GSS</sub>	±20	V
Continuous Drain Current	I <sub>D</sub>	-50	Α
Pulsed Drain Current (Note 2)	I <sub>DM</sub>	-100	Α
Single Pulsed Avalanche Energy (Note 3)	E <sub>AS</sub>	122	mJ
Peak Diode Recovery dv/dt	dv/dt	4	V/ns
Power Dissipation	P <sub>D</sub>	34	W
Junction Temperature	TJ	+150	°C
Storage Temperature	T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 0.1mH,  $I_{AS}$  = -49.4A,  $V_{DD}$  = -50V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25 $^{\circ}$ C
- 4.  $I_{SD} \le -30A$ , di/dt  $\le 200$  A/ $\mu$ s,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$

#### **■ THERMAL DATA**

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	$\theta_{JA}$	62.5	°C/W	
Junction to Case	$\theta_{JC}$	3.68 (Note)	°C/W	

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

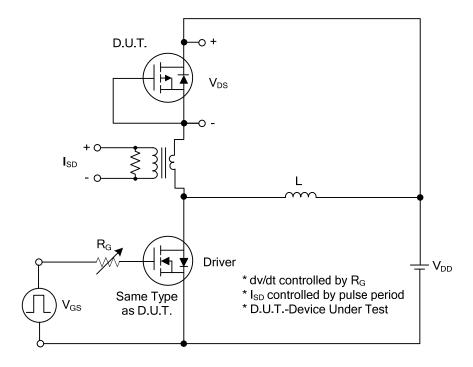
# ■ ELECTRICAL CHARACTERISTICS (T<sub>J</sub> =25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS				•		
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0 V, I <sub>D</sub> =-250μA	-100			V
	I <sub>DSS</sub>	V <sub>DS</sub> =-100V, V <sub>GS</sub> =0V			-1	μA
Drain-Source Leakage Current		V <sub>DS</sub> =-100V, T <sub>C</sub> =125°C			-10	μA
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
ON CHARACTERISTICS	_					
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{DS}=V_{GS}$ , $I_{D}=-250\mu A$	-2.0		-4.0	<b>V</b>
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-25A			65	mΩ
DYNAMIC PARAMETERS						
Input Capacitance	C <sub>ISS</sub>			4670		pF
Output Capacitance	Coss	V <sub>DS</sub> =-25V, V <sub>GS</sub> =0V, f=1.0MHz		221		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			167		pF
SWITCHING PARAMETERS		_	ā.		ā.	
Total Gate Charge	$Q_G$			70		nC
Gate Source Charge	Q <sub>GS</sub>	V <sub>DS</sub> =-80V, V <sub>GS</sub> =-10V, I <sub>D</sub> =-50A -(Note 1, 2)		17		nC
Gate Drain Charge	$Q_GD$	(Note 1, 2)		22		nC
Turn-ON Delay Time	t <sub>D(ON)</sub>			16		ns
Turn-ON Rise Time	t <sub>R</sub>	$V_{DD}$ =-50V, $V_{GS}$ =-10V, $I_{D}$ =-50A,		19		ns
Turn-OFF Delay Time	t <sub>D(OFF)</sub>	R <sub>G</sub> =6Ω (Note 1, 2)		60		ns
Turn-OFF Fall-Time	t <sub>F</sub>			23		ns
SOURCE- DRAIN DIODE RATINGS AN	D CHARACTI	ERISTICS				
Maximum Continuous Drain-Source	I-				-50	Α
Diode Forward Current	Is				-50	A
Maximum Pulsed Drain-Source Diode	I <sub>SM</sub>				-100	Α
Forward Current	ISM				-100	^
Diode Forward Voltage	$V_{SD}$	V <sub>GS</sub> =0V, I <sub>S</sub> =-50A			-1.4	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	V <sub>GS</sub> = 0V, I <sub>S</sub> =-30A,		63		ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	dI <sub>F</sub> /dt=100A/μs (Note 1)		140		μC

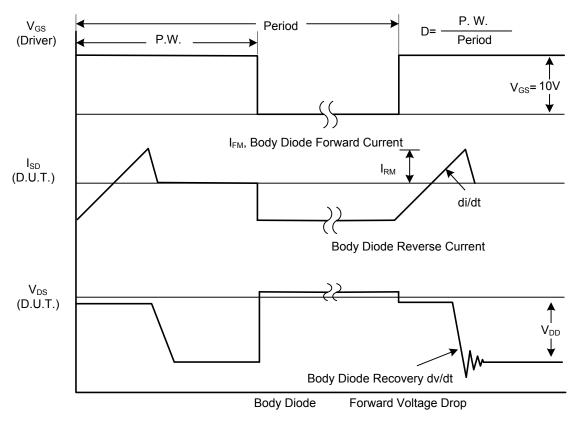
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

<sup>2.</sup> Essentially independent of operating temperature.

# **■ TEST CIRCUITS AND WAVEFORMS**

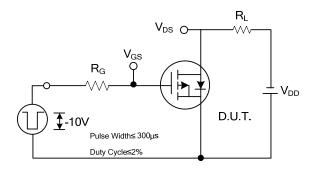


Peak Diode Recovery dv/dt Test Circuit

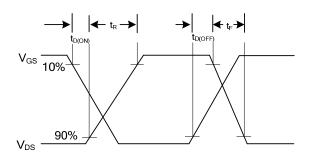


Peak Diode Recovery dv/dt Waveforms

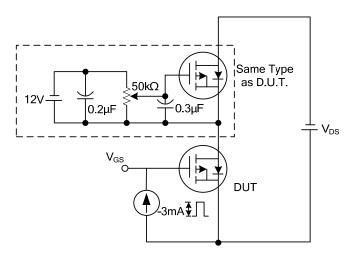
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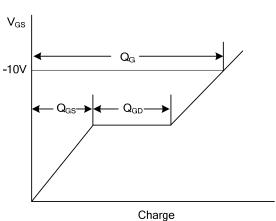
**Switching Test Circuit** 



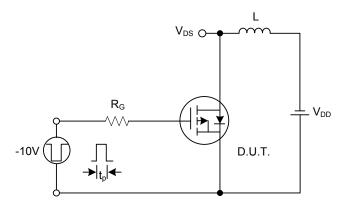
**Switching Waveforms** 



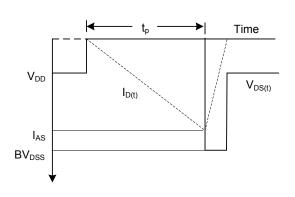
**Gate Charge Test Circuit** 



**Gate Charge Waveform** 



**Unclamped Inductive Switching Test Circuit** 



**Unclamped Inductive Switching Waveforms** 

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